Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/786,960	TANAKA ET AL.	
Examiner	Art Unit	
Tuan V. Thai	2186	

	SEARCHED				
Class	Subclass	Date	Examiner		
711	3	12/5/2005	тн		
711	4	12/5/2005	тн		
711	5	12/5/2005	TH		
711	103	12/5/2005	TH		
711	154	12/5/2005	ΤН		
711	200	12/5/2005	тн		
711	206	12/5/2005	тн		
711	207	12/5/2005	th		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
711	103	12/5/2005	тн		
711	205	12/5/2005	тн		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST searches: DERWENTS USPGPUB EPO/JPO abst IBMTDB NORTH database NPL search IEEE search	12/5/2005	тн		